

OCEENME

OSP4N60C / OSF4N60C 600V N-Channel MOSFET

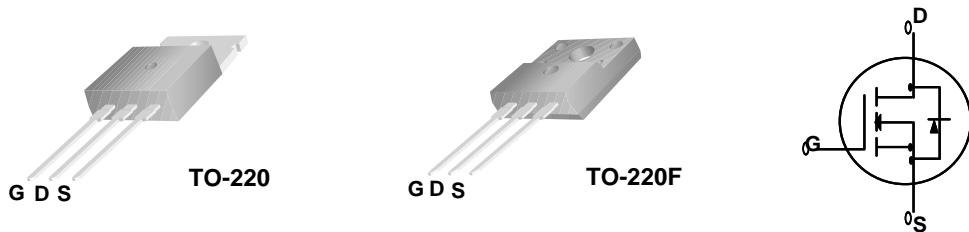
General Description

This Power MOSFET is produced using ocenme's advanced planar stripe DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

- 4.0A, 600V, $R_{DS(on)} = 2.6\Omega$ @ $V_{GS} = 10$ V
- Low gate charge (typical 16nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	OSP4N60C	OSF4N60C	Units	
V_{DSS}	Drain-Source Voltage	600		V	
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$)	4.0	4.0*	A	
	- Continuous ($T_C = 100^\circ\text{C}$)	2.4	2.4 *	A	
I_{DM}	Drain Current - Pulsed	(Note 1)	16	16 *	A
V_{GSS}	Gate-Source Voltage		± 30	V	
E_{AS}	Single Pulsed Avalanche Energy	(Note 2)	160	mJ	
E_{AR}	Repetitive Avalanche Energy	(Note 1)	10	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns	
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	100	33	W	
	- Derate above 25°C	0.8	0.26	W/ $^\circ\text{C}$	
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$	
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	$^\circ\text{C}$	

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	OSP4N60C	OSF4N60C	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.25	3.79	$^\circ\text{C/W}$
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	--	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	$^\circ\text{C/W}$

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Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C	--	0.6	--	$\text{V}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 600 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1	μA
		$V_{\text{DS}} = 480 \text{ V}, T_C = 125^\circ\text{C}$	--	--	10	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA
On Characteristics						
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	2.0	--	4.5	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 2.0 \text{ A}$	--	2.0	2.6	Ω
Y_{FS}	Forward Transconductance	$V_{\text{DS}} = 20 \text{ V}, I_D = 2.0 \text{ A}$	-	4.5	-	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	560	--	pF
C_{oss}	Output Capacitance		--	55	--	pF
C_{rss}	Reverse Transfer Capacitance		--	7	--	pF
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 300 \text{ V}, I_D = 4.0 \text{ A}, R_G = 25 \Omega$ (Note 4, 5)	--	10	--	ns
t_r	Turn-On Rise Time		--	40	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	40	--	ns
t_f	Turn-Off Fall Time		--	50	--	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 480 \text{ V}, I_D = 4.0 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5)	--	16	-	nC
Q_{gs}	Gate-Source Charge		--	2.5	--	nC
Q_{gd}	Gate-Drain Charge		--	6.5	--	μC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current	--	--	4.0	A	
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	16	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_S = 4.0 \text{ A}$	--	--	1.5	V
t_{rr}	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}, I_S = 4.0 \text{ A}, dI_F/dt = 100 \text{ A}/\mu\text{s}$ (Note 4)	--	280	--	ns
Q_{rr}	Reverse Recovery Charge		--	1.8	--	μC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 20mH, $I_{AS} = 4.0 \text{ A}$, $V_{DD} = 50 \text{ V}$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{SD} \leq 4.0 \text{ A}$, $dI/dt \leq 200 \text{ A}/\mu\text{s}$, $V_{DD} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300 \mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

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Typical Characteristics

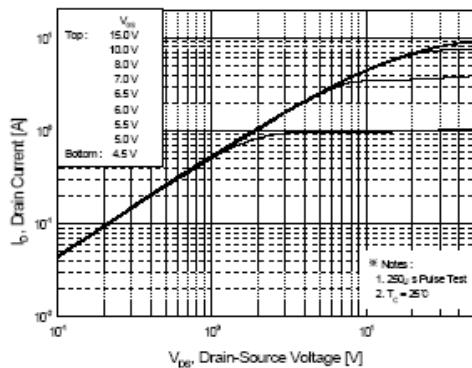


Figure 1. On-Region Characteristics

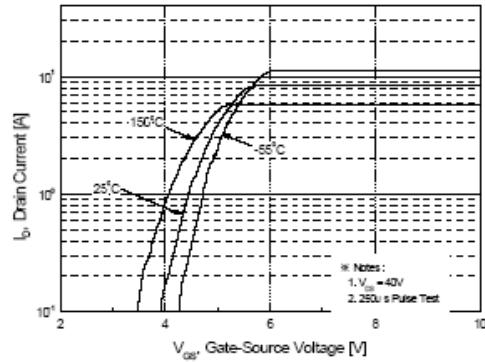


Figure 2. Transfer Characteristics

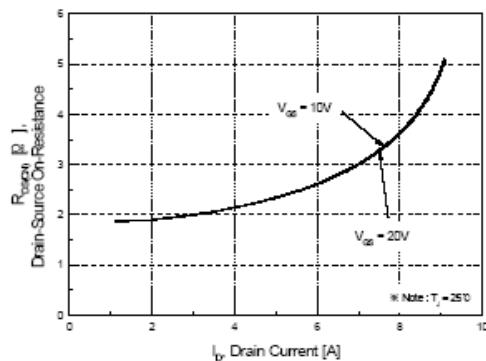


Figure 3. On-Resistance Variation vs
Drain Current and Gate Voltage

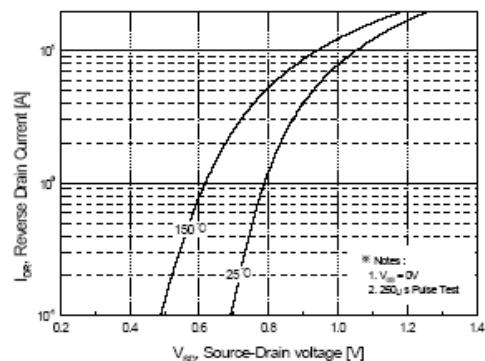


Figure 4. Body Diode Forward Voltage
Variation with Source Current

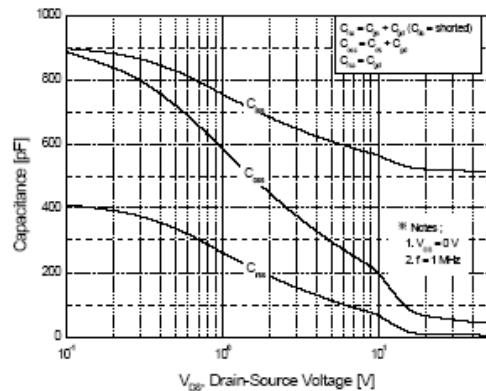


Figure 5. Capacitance Characteristics

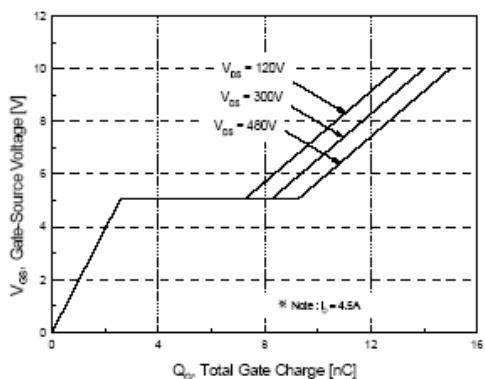
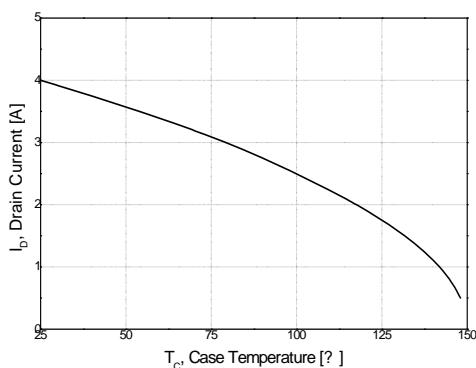
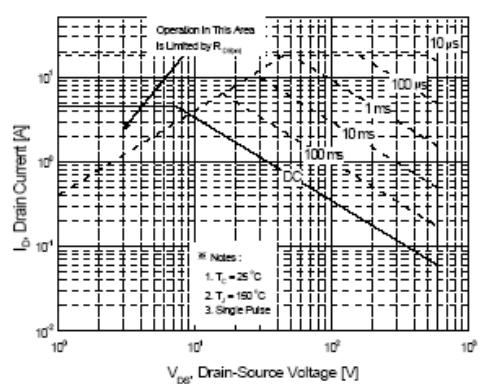
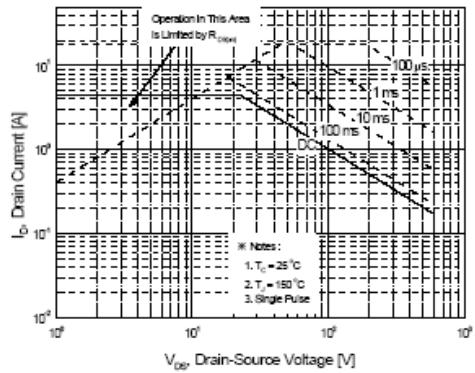
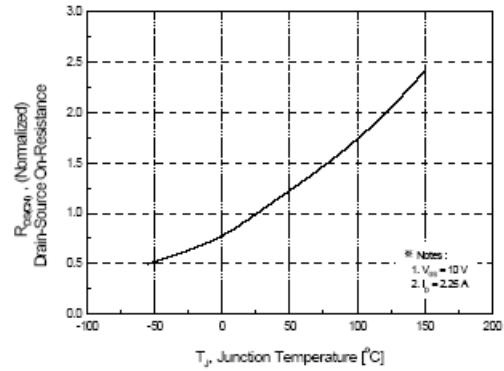
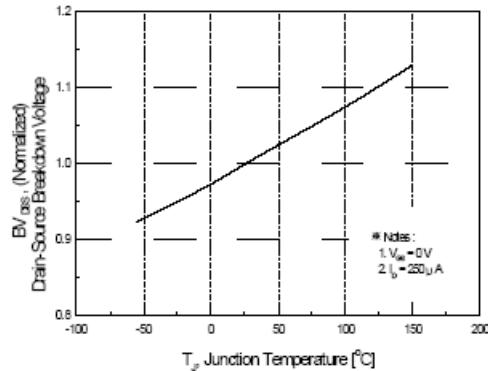


Figure 6. Gate Charge Characteristics

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Typical Characteristics (Continued)



OSP4N60C / OSF4N60C

Typical Characteristics (Continued)

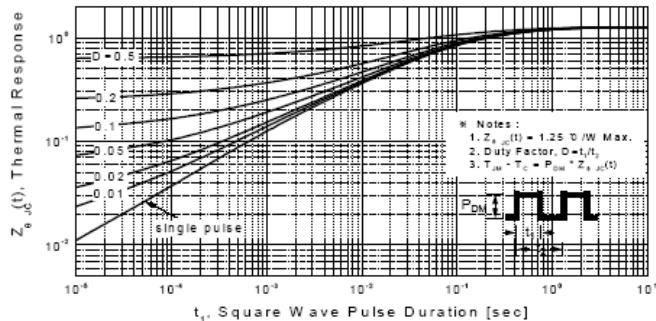


Figure 11-1. Transient Thermal Response Curve
for OSP4N60C

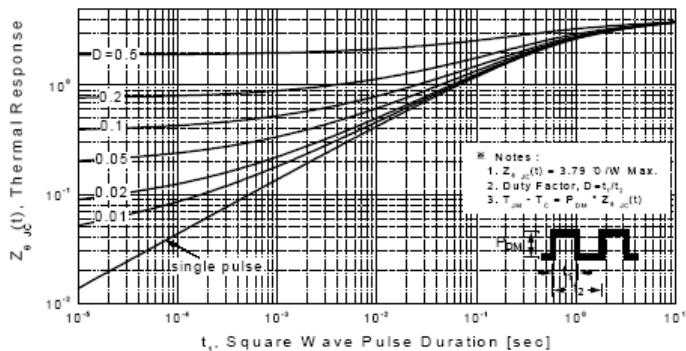
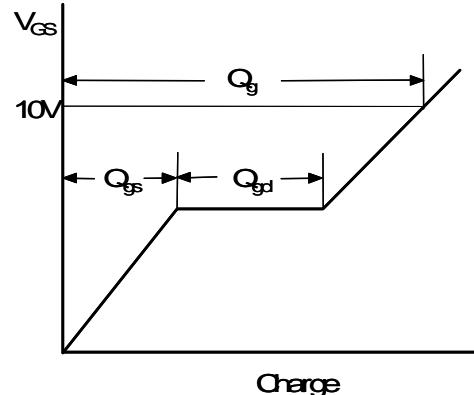
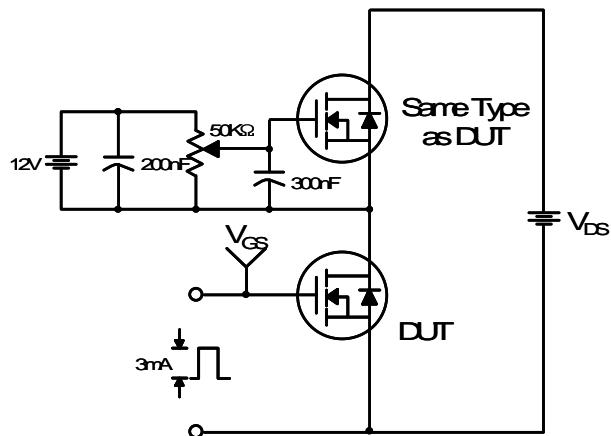


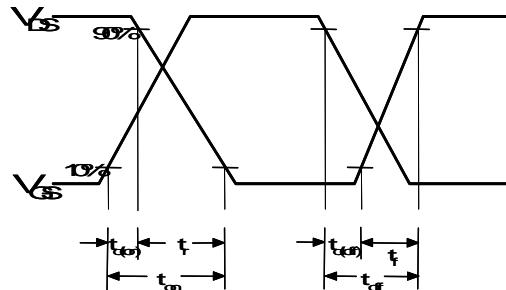
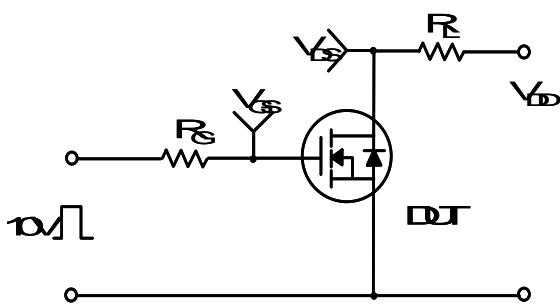
Figure 11-2. Transient Thermal Response Curve
for OSF4N60C

OSP4N60C / OSF4N60C

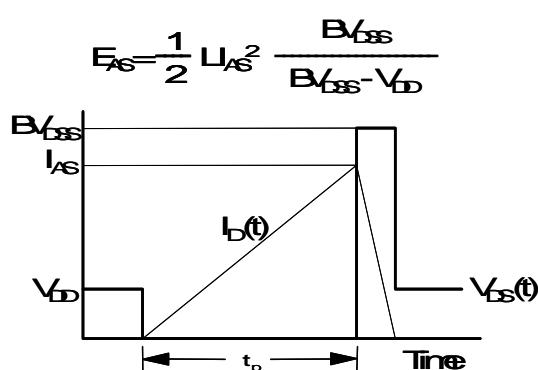
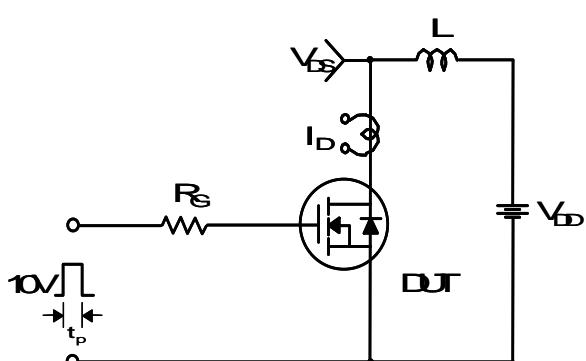
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



OSP4N60C / OSF4N60C

Peak Diode Recovery dv/dt Test Circuit & Waveforms

